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Bib Data Sheet

CONFIRMATION NO. 9883

SERIAL NUMBER 10/625,469	FILING DATE 07/23/2003 RULE	CLASS 324	GROUP ART UNIT 2829	ATTORNEY DOCKET NO. 740756-2632
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** CONTINUING DATA *****

** FOREIGN APPLICATIONS *****

JAPAN 2002-218705 07/26/2002

IF REQUIRED, FOREIGN FILING LICENSE GRANTED

** 12/03/2003

Foreign Priority claimed <input checked="" type="checkbox"/> yes <input type="checkbox"/> no	STATE OR COUNTRY JAPAN	SHEETS DRAWING 14	TOTAL CLAIMS 30	INDEPENDENT CLAIMS 8
35 USC 119 (a-d) conditions met <input checked="" type="checkbox"/> yes <input type="checkbox"/> no <input type="checkbox"/> Met after Allowance				
Verified and Acknowledged Examiner's Signature: <i>[Signature]</i> Initials: <i>28</i>				

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TITLE

Electrical inspection method and method of fabricating semiconductor display devices

FILING FEE RECEIVED 1510	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees <input type="checkbox"/> 1.16 Fees (Filing) <input type="checkbox"/> 1.17 Fees (Processing Ext. of time) <input type="checkbox"/> 1.18 Fees (Issue) <input type="checkbox"/> Other _____ <input type="checkbox"/> Credit
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